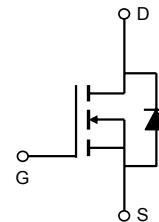


## General Description

The AOL1404 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

## Features

|                                    |         |
|------------------------------------|---------|
| $V_{DS}$                           | 20V     |
| $I_D$ (at $V_{GS}=4.5V$ )          | 45A     |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ )   | < 4mΩ   |
| $R_{DS(ON)}$ (at $V_{GS} = 2.5V$ ) | < 5.6mΩ |



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                               | Symbol           | Maximum    | Units |
|---|------------------|------------|-------|
| Drain-Source Voltage                    | $V_{DS}$         | 20         | V     |
| Gate-Source Voltage                     | $V_{GS}$         | $\pm 12$   | V     |
| Continuous Drain Current <sup>G</sup>   | $I_D$            | 45         | A     |
| $T_C=100^\circ C$                       |                  | 35         |       |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$         | 160        |       |
| Continuous Drain Current <sup>A</sup>   | $I_{DSM}$        | 18         | A     |
| $T_A=70^\circ C$                        |                  | 14         |       |
| Avalanche Current <sup>C</sup>          | $I_{AS}, I_{AR}$ | 57         | A     |
| Avalanche energy $L=0.1mH$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 162        | mJ    |
| Power Dissipation <sup>B</sup>          | $P_D$            | 60         | W     |
| $T_C=100^\circ C$                       |                  | 30         |       |
| Power Dissipation <sup>A</sup>          | $P_{DSM}$        | 2.1        | W     |
| $T_A=70^\circ C$                        |                  | 1.3        |       |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$   | -55 to 175 | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol    | Typ | Max | Units |
|--|-----------|-----|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{0JA}$ | 20  | 25  | °C/W  |
| Maximum Junction-to-Ambient <sup>A,D</sup> |           | 50  | 60  | °C/W  |
| Maximum Junction-to-Case                   | $R_{0JC}$ | 1.8 | 2.5 | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min  | Typ  | Max  | Units            |
|-----------------------------|---------------------------------------|--|------|------|------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |      |      |      |                  |
| $\text{BV}_{\text{DSS}}$    | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$                                 | 20   |      |      | V                |
| $I_{\text{DS}(\text{SS})}$  | Zero Gate Voltage Drain Current       | $V_{DS}=20\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$        |      |      | 1    | $\mu\text{A}$    |
| $I_{\text{GSS}}$            | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$                              |      |      | 100  | nA               |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$                                    | 0.5  | 1    | 1.6  | V                |
| $I_{D(\text{ON})}$          | On state drain current                | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$                                  | 160  |      |      | A                |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance     | $V_{GS}=4.5\text{V}, I_D=20\text{A}$<br>$T_J=125^\circ\text{C}$        |      | 3.3  | 4    | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=2.5\text{V}, I_D=20\text{A}$                                   |      | 4.6  | 5.6  | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=20\text{A}$                                     |      | 4.5  | 5.6  | $\text{m}\Omega$ |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$                                      |      | 0.7  | 1    | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |      |      | 45   | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |      |      |      |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1\text{MHz}$                   | 3080 | 3860 | 4630 | pF               |
| $C_{oss}$                   | Output Capacitance                    |  | 520  | 740  | 960  | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |  | 350  | 580  | 810  | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$                    | 0.6  | 1.4  | 2.1  | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |      |      |      |                  |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=10\text{V}, I_D=20\text{A}$                 | 28   | 36   | 43   | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |  | 7    | 9    | 11   | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |  | 7    | 12   | 17   | nC               |
| $t_{D(on)}$                 | Turn-On Delay Time                    | $V_{GS}=10\text{V}, V_{DS}=10\text{V}, R_L=0.5\Omega, R_{GEN}=3\Omega$ |      | 7    |      | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |      | 8    |      | ns               |
| $t_{D(off)}$                | Turn-Off Delay Time                   |  |      | 70   |      | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |      | 18   |      | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$                        | 13   | 17   | 20   | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$                        | 29   | 36   | 43   | nC               |

A. The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\text{JJA}}$  and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=175^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=175^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

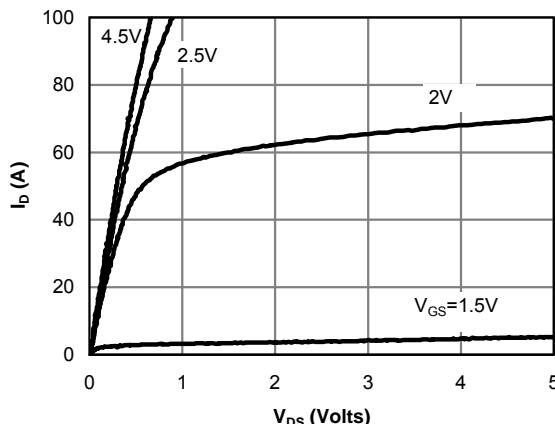
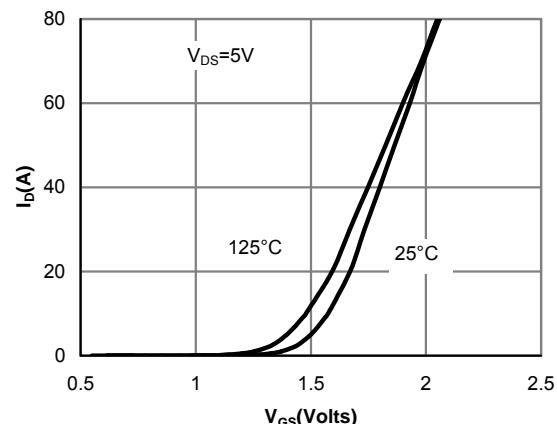
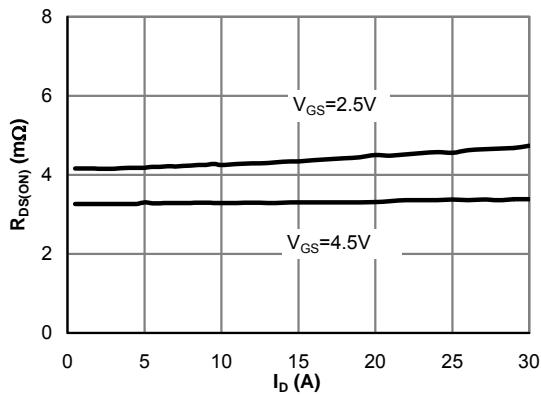
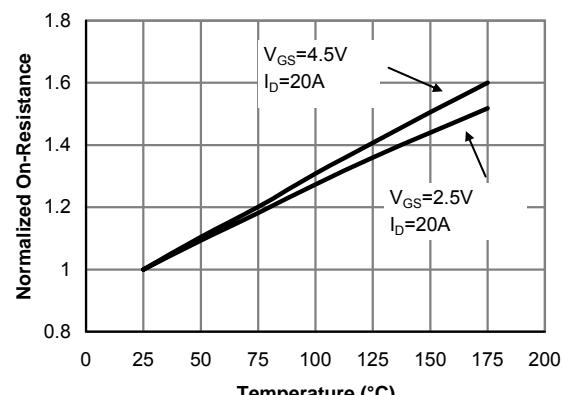
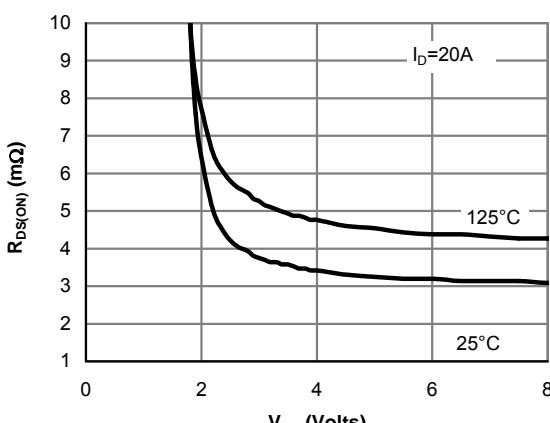
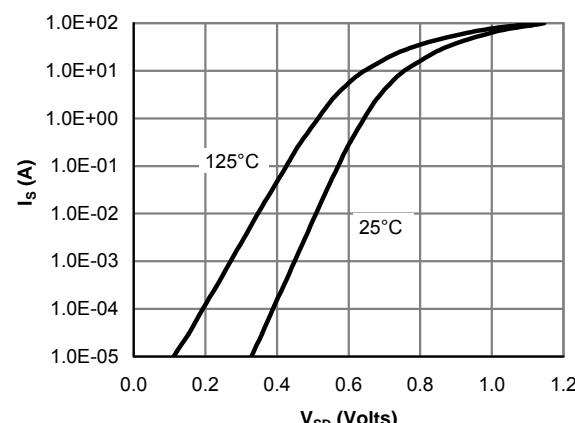
D. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JJC}}$  and case to ambient.

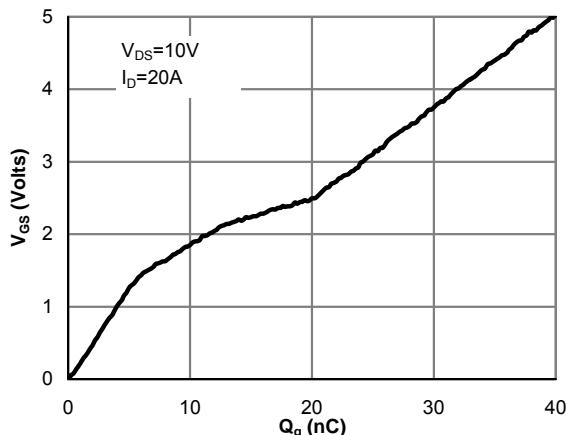
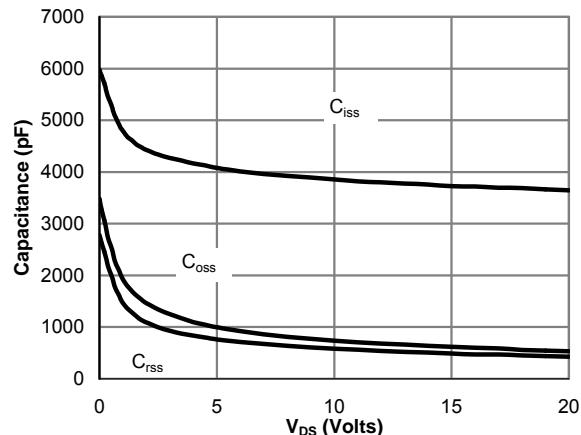
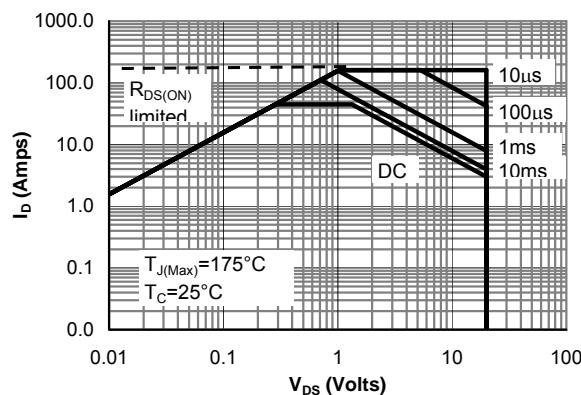
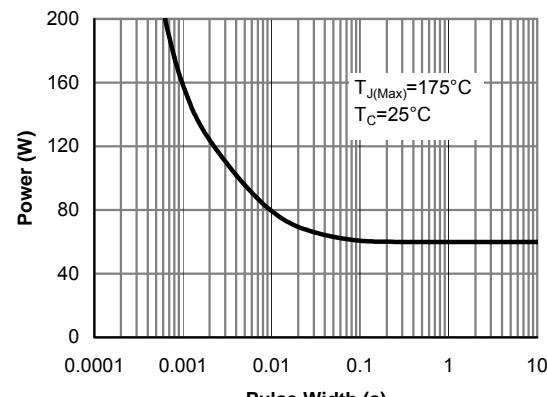
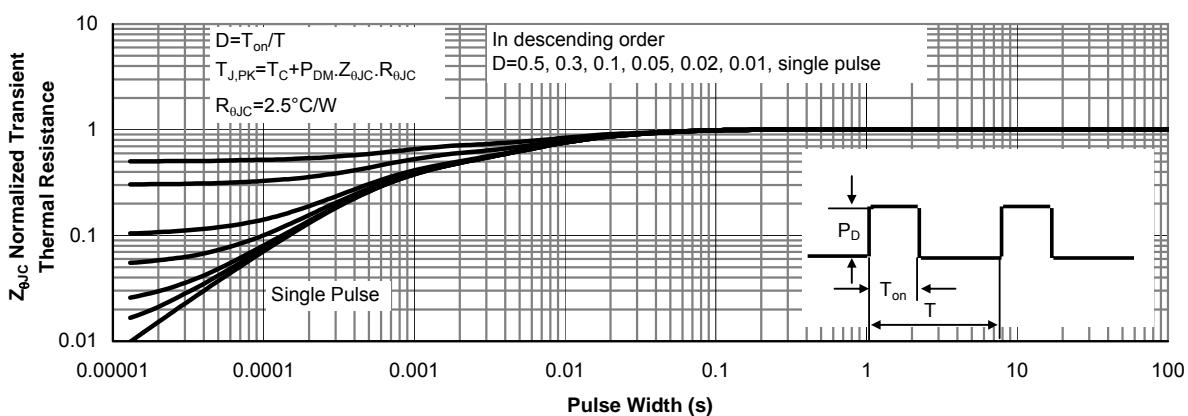
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=175^\circ\text{C}$ . The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Fig 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

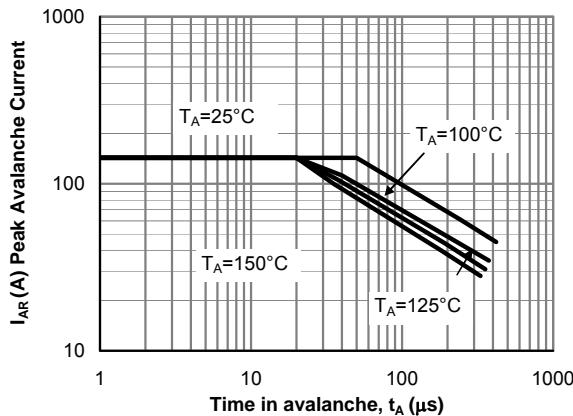
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Figure 12: Single Pulse Avalanche capability (Note C)

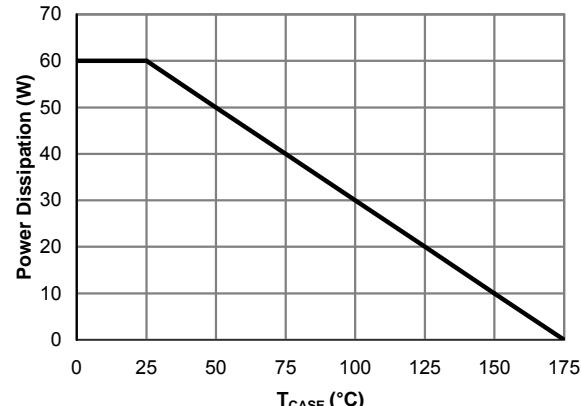


Figure 13: Power De-rating (Note F)

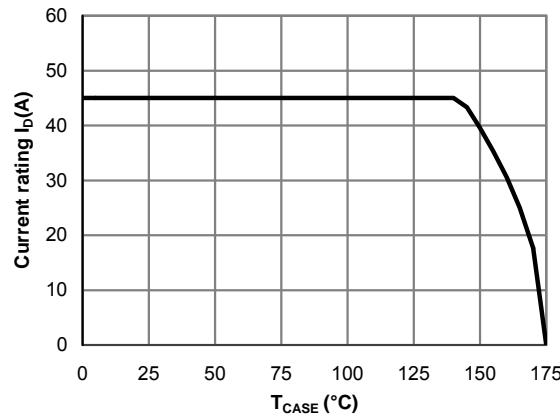


Figure 14: Current De-rating (Note F)

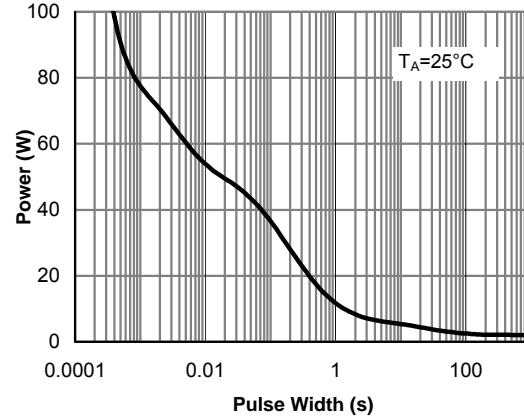


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

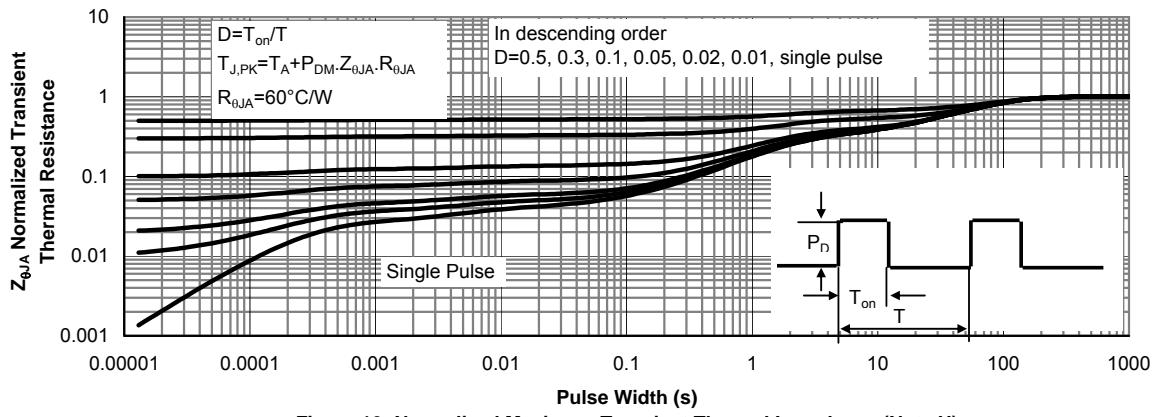
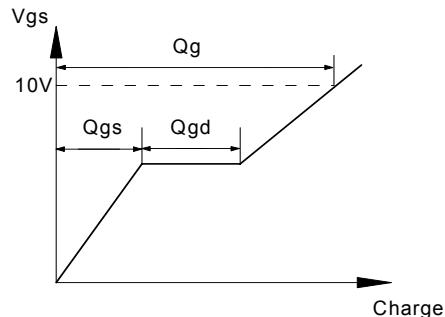
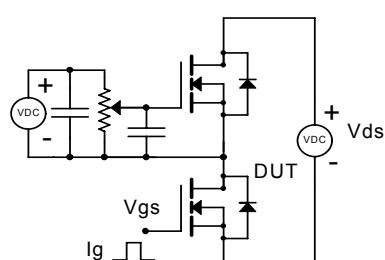
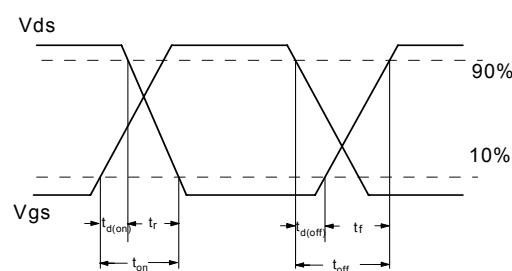
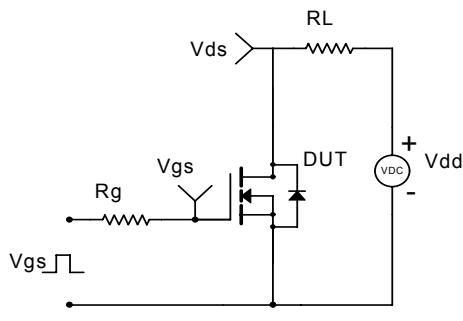


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

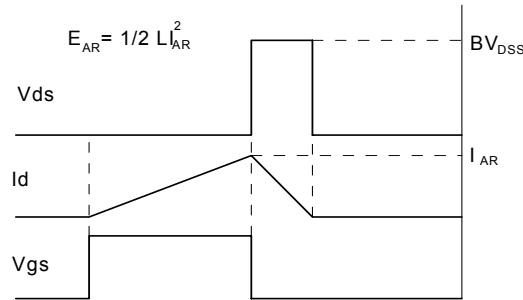
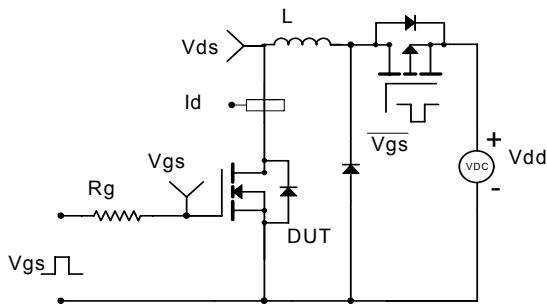
Gate Charge Test Circuit &amp; Waveform



Resistive Switching Test Circuit &amp; Waveforms



Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms

